

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

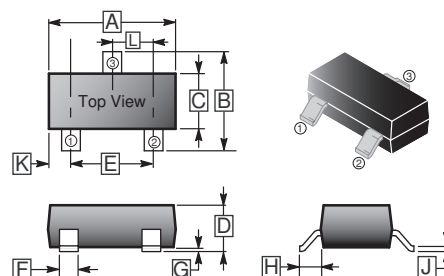
## DESCRIPTION

The miniature surface mount MOSFETs utilize a high cell density trench process to provide low  $R_{DS(ON)}$  and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

## FEATURES

- Low  $R_{DS(ON)}$  Provides Higher Efficiency and Extends Battery Life
- Low Thermal Impedance Copper Leadframe SC-59 Saves Board Space
- Fast Switching Speed
- High Performance Trench Technology

## SC-59



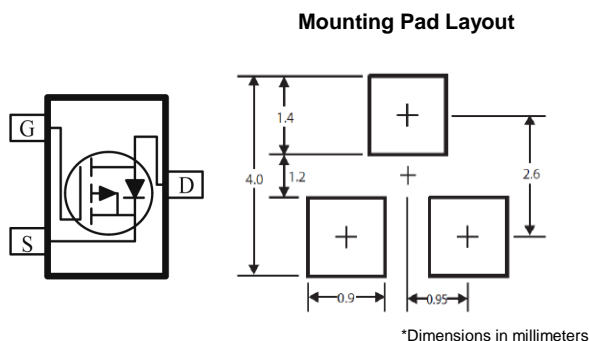
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.10 REF.	
B	2.10	3.00	H	0.40 REF.	
C	1.20	1.70	J	0.047	0.207
D	0.89	1.40	K	0.50 REF.	
E	2.00 TYP.		L	0.95 REF.	
F	0.30	0.50			

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SC-59	3K	7' inch

## ORDER INFORMATION

Part Number	Type
SMG2343P-C	Lead (Pb)-free and Halogen-free



## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	V
Continuous Drain Current <sup>1</sup>	$I_D$	$T_A=25^\circ\text{C}$	-3.6
		$T_A=70^\circ\text{C}$	-2.9
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	$\pm 10$	A
Continuous Source Current (Diode Conduction) <sup>1</sup>	$I_S$	-0.4	A
Power Dissipation <sup>1</sup>	$P_D$	$T_A=25^\circ\text{C}$	1.25
		$T_A=70^\circ\text{C}$	0.8
Operating Junction & Storage Temperature Range	$T_J, T_{STG}$	-55~150	$^\circ\text{C}$
Thermal Resistance Data			
Maximum Thermal Resistance Junction-Ambient <sup>1</sup>	$t \leq 5$ sec	$R_{\theta JA}$	100
	Steady State		150

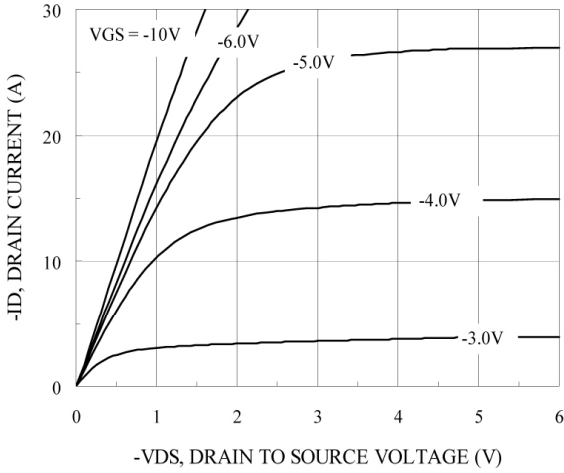
**ELECTRICAL CHARACTERISTICS** ( $T_A=25^\circ C$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate-Threshold Voltage	$V_{GS(th)}$	-0.8	-	-	V	$V_{DS}=V_{GS}, I_D = -250\mu A$
Forward Transconductance <sup>3</sup>	$g_{fs}$	-	2	-	S	$V_{DS} = -5V, I_D = -3.6A$
Gate-Body Leakage	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{DS}=0V, V_{GS} = \pm 20V$
Zero Gate Voltage Drain Current	$I_{DSS}$	-	-	-1	$\mu A$	$V_{DS} = -24V, V_{GS} = 0V$
		-	-	-10		$V_{DS} = -24V, V_{GS} = 0V, T_J = 55^\circ C$
On-State Drain Current <sup>3</sup>	$I_{D(ON)}$	-2	-	-	A	$V_{DS} = -5V, V_{GS} = -4.5V$
Drain-Source On-Resistance <sup>3</sup>	$R_{DS(ON)}$	-	-	57	m $\Omega$	$V_{GS} = -10V, I_D = -3.6A$
		-	-	89		$V_{GS} = -4.5V, I_D = -2.8A$
Diode Forward Voltage	$V_{SD}$	-	-0.7	-	V	$I_S = -0.4A, V_{GS} = 0V$
Total Gate Charge	$Q_g$	-	6.4	-	nC	$I_D = -3.6A$ $V_{DS} = -10V$ $V_{GS} = -5V$
Gate-Source Charge	$Q_{gs}$	-	1.9	-		
Gate-Drain Charge	$Q_{gd}$	-	2.5	-		
Turn-On Delay Time	$T_{d(on)}$	-	10	-	nS	$I_D = -1A$ $V_{DS} = -15V$ $V_{GEN} = -10V$ $R_G = 50\Omega$
Rise Time	$T_r$	-	2.8	-		
Turn-Off Delay Time	$T_{d(off)}$	-	53.6	-		
Fall Time	$T_f$	-	46	-		

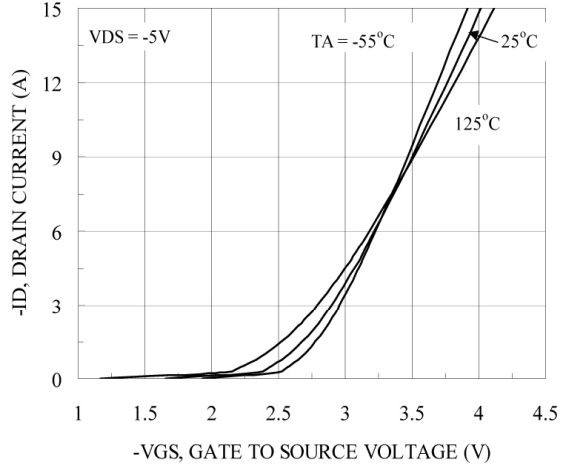
Notes:

1. Surface Mounted on 1" x 1" FR-4 Board.
2. Pulse width limited by maximum junction temperature.
3. Pulse test:  $PW \leq 300\mu s$ , duty cycle  $\leq 2\%$ .

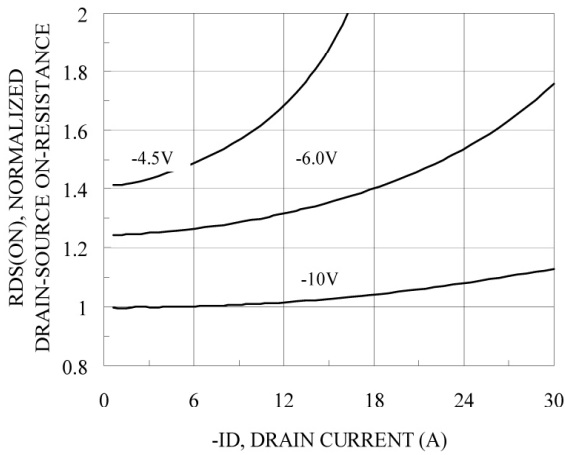
**CHARACTERISTIC CURVE**



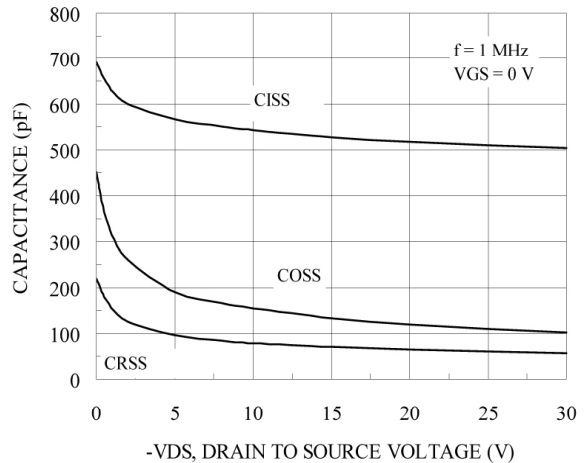
**Figure 1. On-Region Characteristics**



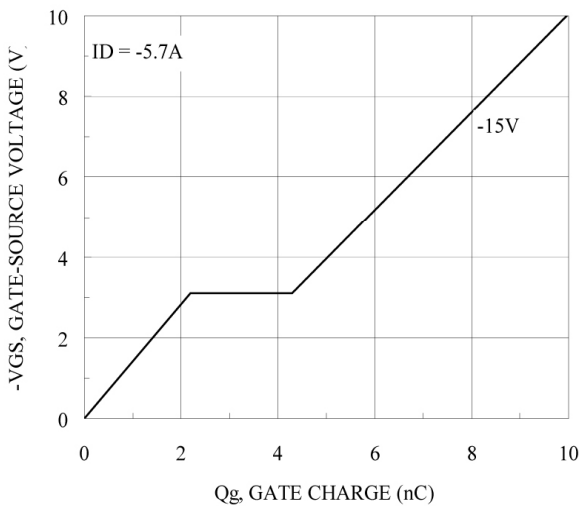
**Figure 2. Body Diode Forward Voltage Variation with Source Current and Temperature**



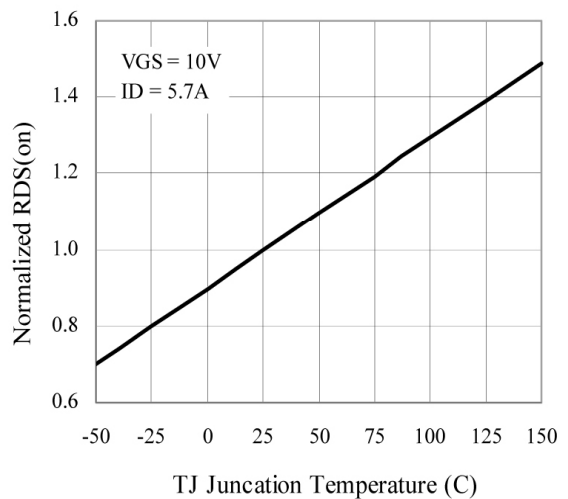
**Figure 3. On Resistance Vs Vgs Voltage**



**Figure 4. Capacitance Characteristics**

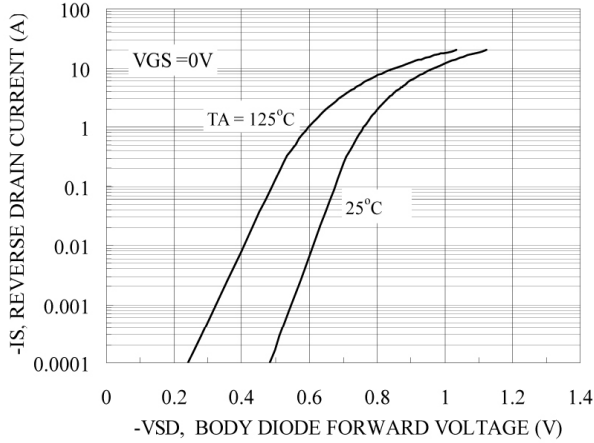


**Figure 5. Gate Charge Characteristics**

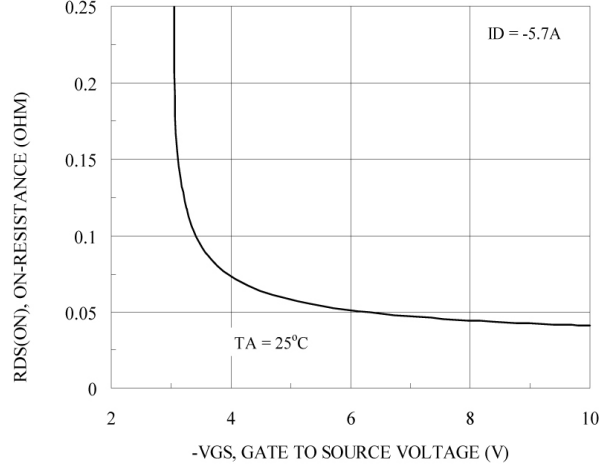


**Figure 6. On-Resistance Variation with Temperature**

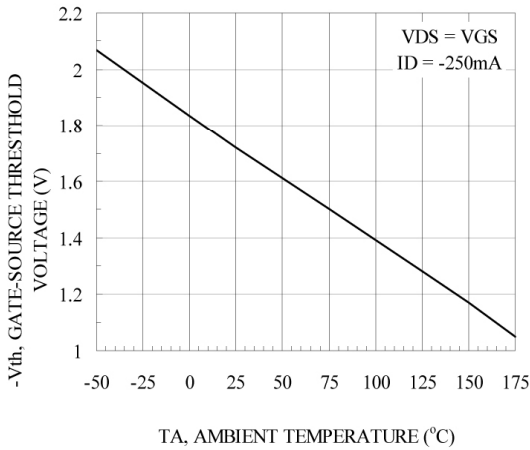
**CHARACTERISTIC CURVE**



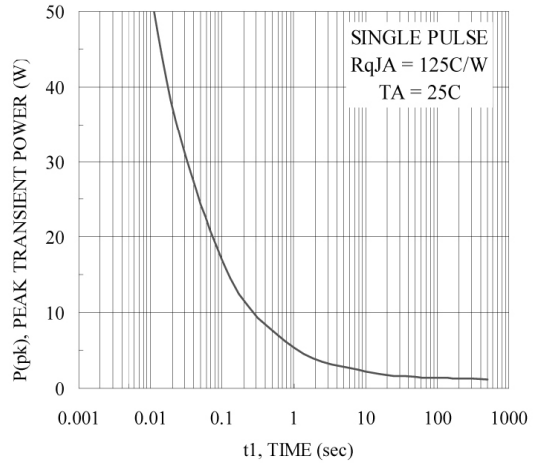
**Figure 7. Transfer Characteristics**



**Figure 8. On-Resistance with Gate to Source Voltage**

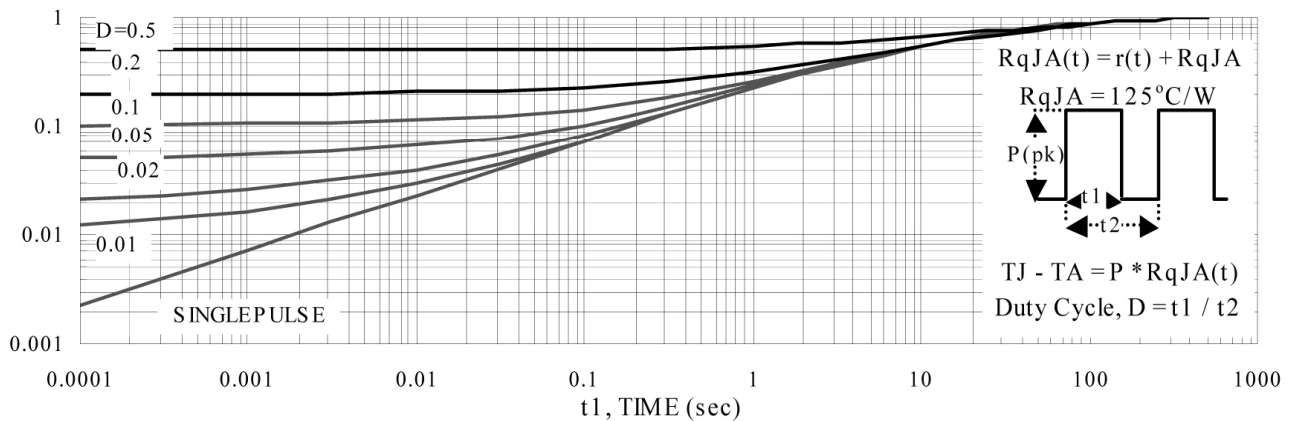


**Figure 9. Vth Gate to Source Voltage Vs Temperature**



**Figure 10. Single Pulse Maximum Power Dissipation**

**Normalized Thermal Transient Junction to Ambient**



**Figure 11. Transient Thermal Response Curve**